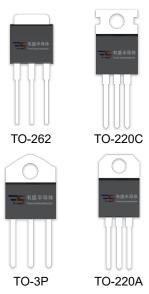


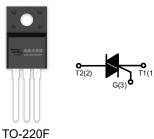
DESCRIPTION:

With high ability to withstand the shock loading of large current, BTA24-800CW series triacs provide high dv/dt rate with strong resistance to electromagnetic interface. With high commutation performances, 3 quadrants products especially recommended for use on inductive load.



MAIN FEATURES

Symbol	Value	Unit
I _{T(RMS)}	25	Α
V _{DRM} /V _{RRM}	600/800/1200/1600	V



ABSOLUTE MAXIMUM RATINGS

Parameter		Symbol	Value	Unit
Storage junction to	emperature range	T _{stg}	-40-150	$^{\circ}\!\mathbb{C}$
Operating junction temperature range		Tj	-40-125	$^{\circ}\!\mathbb{C}$
Repetitive peak of	f-state voltage (T _j =25℃)	V _{DRM}	600/800/1200/1600	V
Repetitive peak re	verse voltage (Tj=25℃)	VRRM	600/800/1200/1600	V
RMS on-state current	TO-220A(Ins)/ TO-220F(Ins) (Tc=70°C) TO-220C/ TO-220A(Non-Ins) (Tc=85°C) TO-262 (Tc=50°C) TO-3P(Ins) (Tc=95°C)	I _{T(RMS)}	25	Α
Non repetitive surge peak on-state current (full cycle, F=50Hz)		Ітѕм	250	А
I ² t value for fusing (tp=10ms)		l ² t	340	A ² s



Critical rate of rise of on-state current $(I_G = 2 \times I_{GT})$	dI/dt	50	A/µs
Peak gate current	I _{GM}	4	Α
Average gate power dissipation	P _{G(AV)}	1	W
Peak gate power	P _{GM}	10	W

ELECTRICAL CHARACTERISTICS (T_j =25 $^{\circ}$ C unless otherwise specified)

 $V_{DRM} / V_{RRM} : 600 / 800 V$

Symbol	Test Condition Quadrant	Quadrant		JST24-600/800V		Unit
		Quadrani		BW	CW	Uill
Ідт	V _D =12V R _L =33Ω	I - II -III	MAX	50	35	mA
V _G T	VD - 12V KL - 3312	I - II -III	MAX	1	.3	V
V _{GD}	$V_D = V_{DRM} T_j = 125$ °C $R_L = 3.3$ ΚΩ	I - II -III	MIN	0.2		V
IL	I _G =1.2I _{GT}	I -III	MAX	80	70	mΛ
		II	IVIAA	100	80	mA
Ін	I _T =100mA		MAX	75	50	mA
dV/dt	V _D =2/3V _{DRM} Gate Open T _j =125℃		MIN	1000	500	V/µs

V_{DRM} /V_{RRM}: 1200/1600V

Symbol	Test Condition Quad	Quadrant	JST24-1200V/1600V		Unit	
				BW	CW	Jill
lgт	V _D =12V R _L =33Ω	I - II -III	MAX	50	35	mA
V _G T	VD - 12V KL-3312	I - II -III	MAX	1	.5	V
V _{GD}	$V_D = V_{DRM} T_j = 125$ °C $R_L = 3.3$ ΚΩ	I - II -III	MIN	0.2		V
I.	I _G =1.2I _{GT}	I -III	MAX	90	70	mA
l _L		II	IVIAA	100	80	IIIA
Ін	I _T =100mA		MAX	80	60	mA
dV/dt	V _D =2/3V _{DRM} Gate Open T _j =125℃		MIN	1500	1000	V/µs



V_{DRM} /V_{RRM}: 600/800V

Symbol	Test Condition	Quadrant		JST24-6	600/800V	Linit
				В	С	Unit
l	V _D =12V R _L =33Ω	I - II -III	MAY	50	25	m 1
I _{GT}		IV MAX	IVIAA	70	50	mA
V _{GT}		ALL	MAX	1	.3	V
V _{GD}	$V_D = V_{DRM} T_j = 125^{\circ}C$ $R_L = 3.3 K\Omega$	ALL	MIN	0.2		V
I.	I _G =1.2I _{GT}	I -III-IV	MAX	80	70	m A
l L		II	IVIAA	100	90	mA
I _H	I _T =100mA		MAX	75	60	mA
dV/dt	V _D =2/3V _{DRM} Gate Open T _j =125℃		MIN	500	200	V/µs

STATIC CHARACTERISTICS

Symbol	Parameter		Value(MAX)	Unit
V _{TM}	I _{TM} =35A tp=380μs	T _j =25℃	1.5	٧
IDRM	\\ _\\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\	T _j =25℃	5	μA
IRRM	$V_D = V_{DRM} V_R = V_{RRM}$	T _j =125℃	3	mA

THERMAL RESISTANCES

Symbol	Parame	Value	Unit	
		TO-220A(Ins)	1.5	
	junction to case(AC)	TO-220C/ TO-220A(Non-Ins)	1.1	°C/W
Rth(j-c)		TO-220F(Ins)	1.7	
		TO-262	2.1	
		TO-3P(Ins)	0.67	



FIG.1: Maximum power dissipation versus RMS on-state current

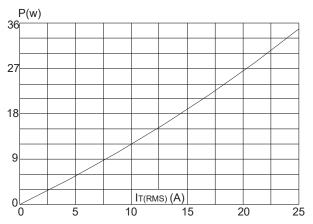


FIG.3: Surge peak on-state current versus number of cycles

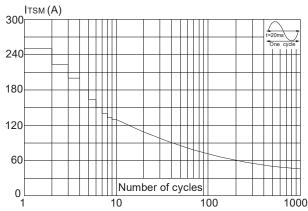


FIG.5: Non-repetitive surge peak on-state current for a sinusoidal pulse with width tp<20ms, and corresponging value of I²t (dI/dt < 50A/µs)

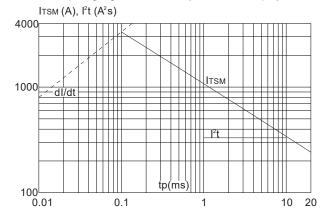


FIG.2: RMS on-state current versus case temperature

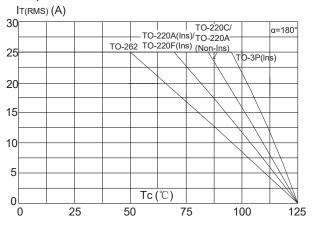


FIG.4: On-state characteristics (maximum values)

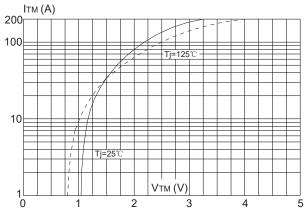


FIG.6: Relative variations of gate trigger current, holding current and latching current versus junction temperature

